

	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/614,928	LEE, JIN-YUAN .
ſ	Examiner	Art Unit
	Douglas M. Menz	2829

SEARCHED							
Class	Subclass	Date	Examiner				
257	700	3/14/05	DM				
	678	1					
	752						
	777						
	774						
	723						
	656						
	676	3/14/65	DW				

INTERFERENCE SEARCHED							
Class	Subclass	Date		Examiner			
257	700 678	3/14/05		VM			
	752 777						
	774 723						
	656	3/14	los	0,1	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
East Send US PAT, US PEPUB, US OCK EPO, JPO, Cenat, IBM TDB	2/22/05	DM			
Updated Sent	3/14/65	DM .			
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